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SHEET 1 OF 3

Substitute for form 1449A/PTO

INFORMATION DISCLOSURE STATEMENT BY APPLICANT

 ATTORNEY'S DKT NO.
005950-720

 APPLICATION NO.
10/047,015

 APPLICANT
Andrew Rainis, et al.

 FILING DATE
January 15, 2002

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U.S. PATENT DOCUMENTS


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Examiner Initials	U.S. Patent Document		Name of Patentee or Applicant of Cited Document	Date of Publication (MM-DD-YYYY)
	Number	Kind Code (if known)		
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	Number	Kind Code (if known)			Yes	no
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JP	0609079	A1	EPA	08-03-1994		
JP	2772784	A1	FR	03-17-1998	abstract only	
JP	2772783	A1	FR	12-24-1997	abstract only	

NON PATENT LITERATURE DOCUMENTS

Examiner Initials	Include name of author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city and/or country where published.		
JP	KAISER, M.A, <i>Chromatography</i> , <u>Kirk Kirk-Othmer: Encyclopedia of Chemical Technology, Chlorocarbons and Chlorohydrocarbons-C, to Combustion Technology</u> , Vol. 6, 4 th Edition, 1993, pp. 207-228, Wiley-Interscience Publication, John Wiley & Sons, New York.		
JP	QUIMBY, B.D., et al., <i>Improved Measurement of Sulfur and Nitrogen Compounds in Refinery Liquids Using Gas Chromatography-Atomic Emission Detection</i> , <u>Journal of Chromatographic Science</u> , Vol. 36, No. 9, September 1998, pp. 435-443. Preston Publications: Division of Preston Industries, Niles, Illinois.		
JP	QUIMBY, B.D., et al., <i>Improved Analysis of Sulfur, Nitrogen, and Other Heteroatomic Compounds in Gasoline-and Diesel-Range Materials Using GC/Atomic Emission Detection</i> , <u>Hewlett Packard: Application Note 228-394, Gas Chromatography</u> , December 1997, pp. 1-11, Hewlett Packard, USA.		
Examiner Signature		Date Considered	8/3/03

EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant. SEND TO: Assistant Commissioner for Patents, Washington, D.C. 20231.

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	Number	Kind Code (if known)			Yes	no

NON PATENT LITERATURE DOCUMENTS

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